NAME

CUTEST cigr – CUTEst tool to evaluate the gradient of a problem function.

SYNOPSIS

```
CALL CUTEST_cigr( status, n, iprob, X, G_val )
```

For real rather than double precision arguments, instead

CALL CUTEST_cigr_s(...)

DESCRIPTION

The CUTEST_cigr subroutine evaluates the gradient of either the objective function or a constraint function of the problem decoded from a SIF file by the script *sifdecoder* at the point X, in the constrained minimization case. The problem under consideration is to minimize or maximize an objective function f(x) o ver all $x \in \mathbb{R}^n$ subject to general equations $c_i(x) = 0$, $(i \in 1, ..., m_E)$, general inequalities $c_i^l \le c_i(x) \le c_i^{u_i}$, $(i \in m_E + 1, ..., m)$, and simple bounds $x^l \le x \le x^u$. The objective function is group-partially separable and all constraint functions are partially separable.

ARGUMENTS

The arguments of CUTEST_cigr are as follows

status [out] - integer

the outputr status: 0 for a successful call, 1 for an array allocation/deallocation error, 2 for an array bound error, 3 for an evaluation error,

n [in] - integer

the number of variables for the problem,

iprob [in] - integer

the number of the problem function to be considered. If iprob = 0, the value of the objective function will be evaluated, while if iprob = i > 0, that of the i-th constraint will be evaluated,

X [in] - real/double precision

an array which gives the current estimate of the solution of the problem,

G_val [out] - real/double precision

an array which gives the gradient of problem function iprob evaluated at X.

AUTHORS

I. Bongartz, A.R. Conn, N.I.M. Gould, D. Orban and Ph.L. Toint

SEE ALSO

CUTEst: a Constrained and Unconstrained Testing Environment with safe threads,

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N.I.M. Gould, D. Orban and Ph.L. Toint,

ACM TOMS, 29:4, pp.373-394, 2003.

CUTE: Constrained and Unconstrained Testing Environment,

I. Bongartz, A.R. Conn, N.I.M. Gould and Ph.L. Toint,

ACM TOMS, 21:1, pp.123-160, 1995.

sifdecoder(1), cutest_cisgr(3)